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Heat-transport mechanisms in molecular building blocks of inorganic/organic hybrid superlattices

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Abstract

Nanomaterial interfaces and concomitant thermal resistances are generally considered as atomic-10 scale planes that scatter the fundamental energy carriers. Given that the nanoscale structural and 11 chemical properties of solid interfaces can strongly influence this thermal boundary conductance, 12 the ballistic and diffusive nature of phonon transport along with the corresponding phonon wave-13 lengths can affect how energy is scattered and transmitted across an interfacial region between 14 two materials. In hybrid composites comprised of atomic layer building blocks of inorganic and 15 organic constituents, the varying interaction between the phononic spectrum in the inorganic crys-16 tals and vibrionic modes in the molecular films can provide a new avenue to manipulate the energy 17 exchange between the fundamental vibrational energy carriers across interfaces. Here, we system-18 atically study the heat transfer mechanisms in hybrid superlattices of atomic- and molecular-layer-19 grown zinc oxide and hydroquinone with varying thicknesses of the inorganic and organic layers 20 in the superlattices. We demonstrate ballistic energy transfer of phonons in the zinc oxide that is 21 limited by scattering at the zinc oxide/hydroquinone interface for superlattices with a single mono-22 layer of hydroquinone separating the thicker inorganic layers. The concomitant thermal boundary 23 conductance across the zinc oxide interfacial region approaches the maximal thermal boundary 24 conductance of a zinc oxide phonon flux, indicative of the contribution of long wavelength vibra-25 tions across the aromatic molecular monolayers in transmitting energy across the interface. This 26 transmission of energy across the molecular interface decreases considerably as the thickness of the 27 organic layers are increased. 28

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30 I. INTRODUCTION

The introduction of material interfaces in solid nanocomposites has provided the op-31 portunity for user-defined thermal transport in nanosystems through manipulation of the 32 fundamental carriers of heat. The inclusion of these interfaces gives rise to both phonon-33 boundary scattering, effectively reducing the thermal conductivity of the solid due to clas-34 sical size effects,¹ and/or partial transmission of thermal energy across the interface driving 35 the thermal boundary conductance.^{2,3} To atomistically manipulate the phonon thermal con-36 ductivity of a nanosystem with a high density of material interfaces, an understanding of 37 the interplay and relationship of phonon-boundary scattering and thermal boundary con-38 ductance across the interfaces must be understood.⁴ Given that the structural and chemical 39 properties of solid interfaces can strongly influence the thermal boundary conductance,⁵ 40 the ballistic or diffusive nature of phonon transport, along with the corresponding phonon 41 wavelengths,⁶ can affect how energy is scattered and/or transmitted across an interfacial 42 region between two materials. This ballistic to diffusive crossover of phonon transport and 43 energy transmission across an atomically thin interface is poorly understood. 44

The consideration of these ballistic and diffusive interfacial phonon energy transport pro-45 cesses has major implications for the development of novel nanomaterials for applications 46 such as thermoelectric energy conversion,^{7–9} where careful placement of interfaces has proven 47 to be useful in efficiently lowering the phononic conductivity while still maintaining elec-48 tronic conductivity. As an example of a novel class of nanocomposites of recent interest, 49 hybrid organic-inorganic nanomaterials grown by a combined alternation of atomic layer 50 deposition (ALD) and molecular layer deposition (MLD) have exhibited enhanced electri-51 cal, optical, magnetic and mechanical functionalities compared to conventional organic or 52 inorganic materials.^{10–13} For example, using this ALD/MLD technique, inorganic/organic 53 superlattices (SLs) have shown promise as potential thermoelectric materials.^{14,15} However, 54 paramount in advancing ALD/MLD hybrid structures for use in thermoelectric, or other 55 applications, is an understanding of the phonon transport and scattering processes in these 56 materials; referring to ALD/MLD SLs, this requires understanding phonon scattering at the 57 ALD/MLD boundary, and its correlation with phonon transmission and resulting bound-58 ary conductance across the molecular interface. There have been limited previous works 59 focusing on measurements of thermal conductivity of ALD/MLD grown materials.^{14,16–18} 60

Given the high density of molecular interfaces in these composite systems, advances in the thermophysics of these materials rely on understanding the thermal conductance across the molecular interfaces.

Given the recent interest in thermal transport in organic-based nanocomposites $^{19-23}$ and 64 heat transport across molecular interfaces,^{24–30} systematically studying the thermal con-65 ductivity of a series of ALD/MLD-grown hybrid SLs also provides an ideal platform to 66 advance our understanding of phonon scattering at, and heat transfer across, thin molecular 67 interfaces. These high quality hybrid nanosystems also provide ideal materials to under-68 stand the heat transfer mechanisms in organic/inorganic SLs, and the interplay between 69 phonon-boundary scattering and thermal boundary conductance across interfaces of identi-70 cal materials separated by a well defined molecular layer. 71

In this manuscript, we study the phonon transport mechanisms in a series of ALD/MLD 72 grown SL thin films comprised of multiple layers of zinc oxide/hyroquinone. The series of SLs 73 include period thicknesses varying from 0.7 nm to 13.1 nm with monolayers of hydroquinone 74 (HQ) interspersed in-between the thicker inorganic layers of ZnO. We also study the effect 75 of the organic layer thickness on the thermal transport across these SLs by investigating 76 a set of samples fabricated by varying the MLD cycles while keeping the thickness of the 77 inorganic layers constant. Additionally, we compare our results of the ZnO-based SLs to 78 that of titanium dioxide (TiO_2) -based SLs (Refs. 17 and 18), to scope the generality of our 79 results. 80

We measure the thermal conductivity, κ , of the SLs providing a platform to study the 81 role of organic interface density on phonon scattering at the inorganic/organic interface and 82 thermal boundary conductance across the inorganic/organic/inorganic interface. We show 83 that thermal transport in ZnO-based hybrid SLs with monolayers of HQ at an interface 84 can be described as a boundary-scattering dominated process that is limited by the period 85 length, thereby reducing the thermal conductance of the crystalline inorganic layer. Our 86 model suggests that nearly the entire spectrum of phonons in the inorganic layer is limited 87 by scattering at the inorganic/organic interface. As an alternative analysis, we determine 88 a mean thermal boundary conductance across the inorganic/organic/inorganic interfaces. 89 The reduction in the transmission of phonons across the ZnO/HQ/ZnO interface leads to 90 an overall reduction in the thermal conductivity of the SLs compared to the thermal con-91 ductivity of a homogeneous ZnO thin film. Furthermore, as we increase the thickness of 92

the organic layers in the SLs, we observe a reduction in the phonon transmission across the inorganic/organic/inorganic interfaces in the hybrid SLs, which results in a reduction in the overall thermal conductivity of the composite.

96 II. EXPERIMENTAL DETAILS

 $(ZnO)_x/HQ$ (where x is the period thickness of the SL) thin films of five different pe-97 riodicities were grown via ALD/MLD on single crystal MgO substrates, an illustration of 98 the structure is shown in Fig. 1a. An additional set of samples were fabricated with three 99 different numbers of HQ layers (i.e., 3, 5 and 7 layers) in-between the ZnO layers with x=7.0100 nm. Diethyl zinc and water were used as precursors for the ZnO layers, while hydroquinone 101 was used for the MLD layers. The depositions were performed at 220°C and consisted of 102 605 ALD/MLD cycles with an ALD:MLD cycle ratio of 99:1, 49:1, 29:1, 9:1 and 4:1. Con-103 trol sample of ZnO thin film with similar thickness as the hybrid SL samples were also 104 fabricated via ALD. X-ray reflectivity (XRR) measurements with a PANalytical X'Pert Pro 105 X-ray diffractometer were used to determine the thickness of the films ($\sim 100 \text{ nm}$) and the 106 SL periods, x. The measured thicknesses are tabulated in Table S1 of the Supplemental 107 Material.³¹ A more detailed description of the film fabrication and characterization can be 108 found in Ref. 32. 109

Characteristic XRR patterns for $ZnO_{x=7.0nm}/5$ and 7 layers of HQ are shown in Fig. 1b. 110 The film thickness dictates the small fringes corresponding to the interference minima and 111 maxima of the reflected beam film-air and film-substrate interfaces, respectively.³³ The XRR 112 also includes interference maxima with higher intensities that represent constructive interfer-113 ence from the periodic introduction of the organic layers. Figure 1c shows the characteristic 114 grazing incidence x-ray diffraction (GIXRD) patterns for the SLs. Typically, the peaks in 115 the XRD patterns were found to fit the typical ZnO hexagonal wurzite structure. As is clear 116 from Fig 1c, there is almost no change in the position of the peaks for the SLs, suggesting 117 that the crystallinity of the ZnO phase is preserved with the inclusion of the HQ layers. 118 However, the intensity of the peaks for the SLs with higher number of organic monolayers 119 (and ALD:MLD cycle ratios of 29:1, 9:1 and 4:1) are reduced compared to the purely ALD 120 grown ZnO film, implying that the crystallinity is hindered to some extent for the inor-121 ganic constituents due to the organic monolayers. For the SL with the thinnest inorganic 122



Figure 1. (a) 2D Schematic representation of the ZnO_x/HQ SL. (b) Characteristic XRR patterns showing SL reflections for ZnO_x/HQ with x=7.0 nm with 5 and 7 layers of HQ separating the 7nm thick inorganic constituents. (c) Characteristic grazing incidence X-ray diffraction (GIXRD) patterns for the control sample and hybrid SLs with varying x. The peaks in the XRD patterns for the hybrid SLs fit to the typical hexagonal wurtzite structure of ZnO (indexed accordingly). There are no shifts in the position of the peaks for the hybrid SLs with ALD:MLD cycle ratios of 99:1, 49:1, 29:1 and 9:1, suggesting that the introduction of the organic monolayers do not affect the crystallinity of the ZnO phase.

¹²³ constituent, the XRD pattern suggests that the inorganic constituents are amorphous.

We use the time domain thermoreflectance technique (TDTR) to measure the thermal 124 properties of the samples. The appropriate analysis procedure for these TDTR measure-125 ments has been previously discussed in detail by several groups.^{34–36} Prior to TDTR measure-126 ments, we metalize the samples with a thin Al layer deposited via electron beam evaporation 127 at 6×10^{-6} Torr. In our TDTR experimental setup, laser pulses emanate from a Ti:Sapphire 128 oscillator with an 80 MHz repetition rate and are energetically split into pump and probe 129 paths. The train of ultra-short pump pulses thermally stimulate the Al metal transducer 130 and time delayed probe pulses measure the change in the thermoreflectance of the sample 131 due to the decay of the deposited thermal energy. We modulate the pump path at 8.8 132 MHz and monitor the ratio of the in-phase to out-of-phase signal of the probe beam from 133 a lock-in amplifier $(-V_{\rm in}/V_{\rm out})$ for up to 5 ns after the initial heating event. To ensure 134 negligible sensitivity to in-plane transport, our pump and probe spot sizes were focused to 135 $1/e^2$ radii values of 30 and 9 μ m, respectively. We measure the thermoreflectance response 136 of each sample in a liquid nitrogen cooled cryostat from 78 to 300 K. We perform several 137

TDTR scans at different locations to ensure repeatability in our measurements. We determine the thermal conductivities and thermal boundary conductances in our samples by fitting our TDTR data to the themral model that accounts for pulse accumulation from the Ti:Sapphire oscillator.^{34–36} The thickness of the Al transducer layer is measured via picosecond acoustics.³⁷

Initially, we fit the time domain thermoreflectance (TDTR) data for our ALD grown 143 control sample with a model that accounts for thermal diffusion in a 3 layer system by 144 fitting for thermal boundary conductances across the Al/ZnO and ZnO/Al₂O₃ interfaces. 145 All other parameters in our thermal model such as the thermal conductivities and heat 146 capacities of the constituent layers are taken from literature;^{38–41} note, due to small thermal 147 resistance of pure ZnO, we are negligibly sensitive to the thermal conductivity of the ZnO 148 thin film and our TDTR data on these control samples are dominated by the thermal 149 boundary conductances $(h_{\rm K})$ at the Al/ZnO and ZnO/Al₂O₃ interfaces, as shown in Fig. 2a 150 and discussed in detail below. 151

To evaluate the thermophysical properties of interest in our control samples, namely the 152 thermal boundary conductances across the Al/ZnO and $\mathrm{ZnO}/\mathrm{Al_2O_3}$ interfaces, we must 153 determine the appropriate range of pump-probe delay times to fit the thermal model to the 154 experimental data, in which the thermal model is extremely sensitive to changes in $h_{\rm K}$.^{36,42} 155 To determine these interface resistances, we use a combination of the in-phase response and 156 the ratio of the in-phase to out-of-phase responses over various pump-probe time delays, 157 due to relative sensitivities to the thermophysical properties of interest in this system. The 158 sensitivity of the in-phase signal to various thermal properties is defined by, 159

$$S_a = \frac{\partial \ln(-V_{\rm in})}{\partial \ln(a)} \tag{1}$$

where a is the thermophysical parameter of interest and V_{in} is directly proportional to the 160 response of the thermoreflectance signal recorded by the lock-in amplifier. Figure 2a shows 161 the sensitivities of V_{in} to the thermophysical properties of interest in our ZnO control sample 162 at 300 K. The sensitivity to $h_{\rm K}$ for the Al/ZnO interface is relatively large and very dynamic 163 for the first nanosecond time delay at both 78 and 300 K. In this time frame, the sensitivities 164 of the other parameters are minimal and therefore will not affect the thermal response of the 165 control sample. Therefore, we fit the in-phase signal with the thermal model by iterating 166 the $h_{\rm K}$ for the Al/ZnO interface and all the other parameters are held constant for 1 ns 167



Figure 2. (a) Sensitivities of the (a) in-phase signal (for a purely ALD grown ZnO thin film) and (b) ratio of the in-phase and out-of-phase signals (for the $(ZnO)_{x=7nm}/HQ$ film) to the thermal boundary conductances at Al/ZnO and ZnO/Al₂O₃ interfaces and thermal conductivities of Al, ZnO and Al₂O₃.

time delay. We note that since fitting the in-phase response of the TDTR signal requires 168 scaling our model to the data at a fixed delay time (which we choose as 100 ps), we become 169 completely insensitive to thermophysical properties that have flat sensitivities in the time 170 domain, further enhancing our accuracy in determining $h_{\rm K}$ over our specified time delay. 171 Similarly, we determine the $h_{\rm K}$ for the ZnO/Al₂O₃ interface by fitting the in-phase signal in 172 the range of 2-5 ns while using the $h_{\rm K}$ for the Al/ZnO interface determined from the first 173 1 ns time delay fit. We discuss this fitting approach in more detail in the Supplemental 174 Material. 175

The measured thermal boundary conductances from the control sample are used as input parameters for thermal conductivity analyses of the superlattice samples ((ZnO)_x/HQ). We fit the ratio of the in-phase and out-of-phase signals $(-V_{in}/V_{out})$ to the 3 layer thermal model to determine the thermal conductivity of the superlattice films. For these fits, we use



Figure 3. Sample data and best-fit curves for the $(ZnO)_{x=7.0 \text{ nm}}/HQ$ (red squares) and $(ZnO)_{x=7.0 \text{ nm}}/HQ$ (black circles) along with uncertainties (dotted lines) at room temperature.

the thermal boundary conductances determined from our in-phase analyses, leaving the only 180 unknown parameter in these measurements as the thermal conductivity of the $(ZnO)_x/HQ$ 181 films. Figure 2b shows the sensitivity of the ratio to the various parameters in our 3-182 layer model for the $(ZnO)_{x=7nm}/HQ$ film. An error of 15% in h_K for the Al/ZnO interface 183 propagates to an error of $\sim 1.5\%$ and $\sim 0.8\%$ on the measured thermal conductivities of 184 the $(ZnO)_{x=13.1 nm}/HQ$ and $(ZnO)_{x=7.0 nm}/HQ$ samples at room temperature, respectively. 185 However, an error of 15% in $h_{\rm K}$ for the ZnO/Al₂O₃ interface causes an error of ~13% and 186 $\sim 7\%$ in the measured conductivities for $(ZnO)_{x=13.1 \text{ nm}}/HQ$ and $(ZnO)_{x=7.0 \text{ nm}}/HQ$ samples 187 at room temperature, respectively. This is a major source of uncertainty reported for our 188 measurements. The fits to the TDTR data along with the uncertainties (dashed lines) for 189 the samples $(ZnO)_{x=7.0 \text{ nm}}/HQ$ and $(ZnO)_{x=13.1 \text{ nm}}/HQ$ at 300 K are shown in Fig. 3. 190

191 III. RESULTS AND DISCUSSIONS

Figure 4 shows the measured thermal conductivities for the $(ZnO)_x/HQ$ SLs with varying x at different sample temperatures. The thermal conductivities of these SLs demonstrate



Figure 4. Measured thermal conductivities as a function of temperature for $(ZnO)_x/HQ$ SLs with varying x. The error bars include uncertainties due to repeatability, Al thickness measurement and uncertainties in the parameters used in the thermal model. Also plotted are the thermal conductivities for a 180 nm ALD-grown homogenous ZnO film taken from Ref. 39.

¹⁹⁴ more than a ten-fold decrease compared to the results for an ALD-grown homogeneous ZnO ¹⁹⁵ thin film³⁹ as shown in Fig. 4. The inclusion of higher interface densities and the reduction ¹⁹⁶ in the inorganic layer thickness results in the reduction of the thermal conductivities of these ¹⁹⁷ hybrid SLs.

To describe the results in Fig. 4, we consider the thermal transport in these hybrid 198 samples being described by a phonon flux in the inorganic material that is limited only by 199 phonon/boundary scattering at the inorganic/organic interface. In other words, we assume 200 that the overall thermal conductivities of the SL films are minimally affected by scattering 201 mechanisms in the bulk of the inorganic constituent (such as phonon-defect or phonon-202 phonon scattering in the individual layers). Therefore, the thermal transport is limited by 203 the combination of the phonon flux, q, in the inorganic layers and the thickness, x, of the 204 layers (i.e., x = period thickness of the SLs). The phonon flux in the inorganic layer can be 205



Figure 5. Thermal conductivity as a function of the inorganic layer thickness for SLs with single HQ layers at 78 K and 300 K. Along with that, the predicted thermal conductivities as a function of SL period thickness calculated from Eq. 2 at 78 K and 300 K are also shown. The effective thermal conductivity model assuming only phonon-boundary scattering at the HQ-layer interface described in Eq. 3 provides reasonable agreement with the measured thermal conductivities for these SLs. (inset) The thermal conductivity for these hybrid SLs is inversely proportional to the ZnO/HQ/ZnO interface density.

²⁰⁶ approximated by,⁴³

$$q = \frac{1}{8\pi^2} \sum_j \int_{k_1} \hbar \omega k^2 v_j f \mathrm{d}k \tag{2}$$

where, j is the polarization, ω is the phonon frequency, \hbar is Planck's constant, f is the Bose-Einstein distribution and v is the group velocity. Equation 1 assumes an isotropic, spherical Brillouin zone to predict the heat flux in the inorganic ZnO layers. We note that this assumption correctly predicts the volumetric heat capacity of ZnO (further details of the assumptions and our calculations are provided in the Supplemental Material). With the flux, q, determined from the phonon dispersion, the effective thermal conductivity of the ²¹³ SLs that is dictated by the period thickness x, is given by,

$$\kappa_{\text{effective}} = \frac{1}{3} \int C_k v_k \mathrm{d}k \, \mathbf{x} = \frac{\partial q}{\partial T} \mathbf{x} \tag{3}$$

where T is temperature and C_k is the spectral phonon heat capacity. Equation 3 assumes 214 that phonon transport in the inorganic layer is ballistic and that the phonons scatter only 215 at boundaries that restore local thermodynamic equilibrium. As such, our discussion and 216 analyses assume that the interfacial organic boundaries are considered to be reflectionless 217 and black, and the phonon flux is assumed to thermalize at these boundaries. Calculations 218 of Eq. 3 for ZnO at two temperatures as a function of x are shown in Fig. 5. For these 219 calculations, we use all 12 branches of the bulk phonon dispersion relation for ZnO in the 220 $\Gamma \rightarrow M$ direction, as calculated in Ref. 44 via *ab initio* methods. The measured thermal 221 conductivities at 78 K and 300 K for the SLs show good agreement with our calculations 222 of Eq. 3, supporting our assertion that size effects in the inorganic layers of the hybrid SLs 223 limit thermal transport. This analysis assumes that the entire spectrum of phonon mean free 224 paths in the ZnO layer is limited by scattering at the inorganic/organic/inorganic interface. 225 The drastic reduction in the thermal conductivity values decreasing period in the SLs is 226 clearly seen by the inverse relationship of κ with ZnO/HQ/ZnO interface density as shown 227 in the inset of Fig. 5. To scope the generality of these results to hybrid SLs, we compare the 228 measured thermal conductivity of 3.1 ± 0.2 W m⁻¹ K⁻¹ for a (TiO₂)_x/HQ SL with x=15.5 220 nm at room temperature to the thermal conductivity measurement for a homogeneous TiO_2 230 thin film $(5.2 \pm 0.3 \text{ W m}^{-1} \text{ K}^{-1})$.^{17,18} The reduction in thermal conductivity for the TiO₂-231 based SL is in line with the results reported for the $(ZnO)_x/HQ$ SLs. This reduction in 232 the thermal conductivity due to the periodic monolayers is consistent with the decrease in 233 thermal conductivity with increased interface density in inorganic SLs.^{45,46} 234

As pointed out in purely inorganic SLs, the monotonic decrease in thermal conductivity 235 due to increased interface density (and linearly increasing thermal resistance with increasing 236 interface density) is due to incoherent scattering, where the phonons behave as particles and 237 lose their phase information by scattering at the internal boundaries.^{45,46} Ravichandran 238 et al.⁴⁵ have shown that by increasing the interface density (decreasing period thicknesses) 239 beyond the incoherent regime, the phonon dispersion in inorganic SLs can be altered by 240 mini-band formation, which effectively preserves the coherent nature of phonon transport 241 in these SLs. An alternative wave nature of phonon transport in inorganic SLs has also 242

²⁴³ been demonstrated by Luckyanova *et al.*,⁴⁷ where they varied the total thickness of the ²⁴⁴ inorganic SL films while keeping the SL period thicknesses constant and showed an increase ²⁴⁵ in the thermal conductivity. Our results for the hybrid SLs are consistent with the particle ²⁴⁶ nature of phonon transport (or the incoherent scattering regime) as demonstrated by the ²⁴⁷ monotonically decreasing thermal conductivity with increasing interface densities (see inset ²⁴⁸ of Fig. 5).

The appreciable agreement between our measured values for a wide range of inorganic 249 layer thicknesses and that predicted by the model in Eq. 3 (as shown in Fig. 5) suggests that 250 the phonon flux in the inorganic layer is mostly ballistic and the phonon mean free path is 251 limited by the ZnO layer thicknesses. However, for thicker inorganic layers, where phonon-252 phonon scattering in the bulk of the inorganic layer creates a temperature gradient along 253 the layer, the validity of Eq. 3 in describing thermal transport in these SLs is questionable. 254 In fact, this is exemplified by the disagreement between the prediction of Eq. 3 for x = 13.1255 nm and the experimentally measured κ for $(ZnO)_{x=13.1nm}/HQ$. Therefore, by describing the 256 thermal transport by Eq. 3, we have considered the thermal conductivities of these hybrid 257 SLs to be driven by a ballistic phonon flux limited by scattering at the inorganic/organic 258 interface, which clearly breaks down as the ZnO thickness increases. Therefore, to study the 259 validity and range of applicability of this hypothesis, we consider an alternative analysis of 260 our results in Figs. 4 and 5 by considering the reduction in thermal conductivity to be driven 261 by a thermal boundary conductance across the inorganic/organic/inorganic interface. This 262 approach will give quantitative insight into the role of phonon transmission across the inor-263 ganic/organic/inorganic interface on our measured thermal conductivities. Note, as we are 264 not able to separate the individual resistances due to scattering at the ZnO/HQ boundaries 265 and the internal scattering in the HQ layer, we couple these scattering mechanisms into a 266 lumped resistance in our discussions and analysis presented below. 267

In the typical semi-classical picture of thermal boundary conductance across solid interfaces (i.e., the acoustic or diffuse mismatch models^{2,48,49}), a mismatch in acoustic properties or vibrational density of states, limits the interfacial phonon transmission, and therefore restricts the phonon flux that transmits across the organic-based interfaces. The acoustic mismatch model (AMM) considers phonons as plane waves and the lattice as a continuum solid and assumes specular reflection and transmission of phonon energy at the interface, whereas the diffuse mismatch model (DMM) disregards this complete specularity at the

interface. These models could potentially offer complementary, yet alternative insight into 275 the mechanisms driving the large reduction in the measured thermal conductivity of these 276 hybrid SLs, and elucidate the role of the organic monolayers and their intrinsic vibrational 277 properties on phonon transport. We model the thermal boundary conductance $(h_{\rm K})$ through 278 the organic interface, which is described by the temperature derivative of the phonon flux 279 (as described in Eq. 2) with the inclusion of a transmission coefficient $(\zeta_{1\to 2})$ from side 1 to 2 280 (from inorganic, through the organic monolayer, and emitted into the next inorganic layer). 281 The thermal boundary conductance is defined based on the temperature of the incident 282 and emitted phonons, and therefore it predicts a finite interfacial conductance (as opposed 283 to an infinite conductance or zero thermal boundary resistance) for an imaginary interface 284 comprising of the same material.⁵⁰ This conductance occurs when $\zeta_{1\rightarrow 2}=1$ and all available 285 phonon modes are transmitted from side 1 to 2 of the imaginary interface in the crystal. We 286 note that by this definition, the maximum possible thermal boundary conductance for an 287 imaginary interface is solely limited by the phonon flux that impinges upon the interface. 288 Alternatively, assuming an interface between two materials that causes diffusive scattering, 289 this maximum limit is described by a transmission of $\zeta = 0.5$. 290

To consider the possibility of the thermal boundary conductance across the inor-291 ganic/organic/inorganic interface-limiting the thermal transport across the SLs, we model 292 $h_{\rm K}$ across the ZnO/HQ/ZnO interface assuming maximal phonon transmission. This as-293 sumption implies that the phonon transmission from the ZnO across the HQ is unimpeded 294 by any properties of the HQ; that is, we assume $\zeta_{1\to 2}=1$. For these calculations, we make the 295 same assumptions for ZnO density of states and phonon velocities as in Eq. 2. Calculation 296 of this maximal conductance at room temperature for a ZnO phonon flux is shown in Fig. 6a 297 (dashed line). In most real nanosystems, due to both a mismatch of vibrational density 298 of states and imperfections around the interfacial regions, the transmission coefficient is 299 not unity (for a review of thermal boundary conductance dictated by various interfacial 300 conditions, readers are referred to Ref. 5). For this reason, the measured values of $h_{\rm K}$ in 301 the literature have never exceeded this maximum thermal boundary conductance for any 302 interface. 303

From the measured thermal conductivities in our hybrid SLs, we derive the mean thermal boundary conductance across the individual ZnO/HQ/ZnO interfaces with a series resistor model, which assumes that phonons can only scatter at the ZnO/HQ/ZnO interfaces (con-



Figure 6. (a) The mean thermal boundary conductances of interfaces in ZnO_x/HQ SLs derived from thermal conductivity measurements shown in Fig. 4. Also plotted are the mean conductances of interfaces in W/Al₂O₃ SLs⁵¹ and AlN/GaN SLs⁵² for comparison (b) The mean thermal boundary conductances derived for x=7.0 nm and 13.1 nm as a function of temperature for the ZnO based SLs. The calculations of maximum conductance in ZnO with phonon transmission coefficient equal to unity are also shown. Also included for comparison is the calculation of the DMM for a ZnO/ZnO interface (i.e., 50% transmission of the ZnO phonon flux).

sistent with our previous analysis where we assume that the phonon flux is only scattered at the ZnO/HQ boundaries). We calculate the mean conductance across the HQ layers as $h_{\rm K} = 1/R_{\rm K} = (\kappa_{\rm ZnO_x/HQ} n)/d$, where n is the number of inorganic/organic/inorganic interfaces and d is the total thickness of the hybrid films. To reiterate, this formulation of $1/R_{\rm K}$ implies that the resistance due to the individual ZnO/HQ interfaces and the intrinsic resistance of the organic molecules comprising the interface are lumped as a single resistor.

Figure 6a shows the mean thermal conductance for ZnO/HQ/ZnO interfaces as a function of the inorganic layer thickness (hollow squares). Two aspects of the results for the conductance calculations shown in Fig. 6a are worth noting. First, the values of the mean conductances for these SLs among the various samples are agreeable within the uncertainties, regardless of the ZnO/HQ/ZnO interface density. This suggests that the series resistor model used to derive these conductances is applicable for our hybrid SLs with single HQ layers, and our previous assumption and discussion regarding fully thermalizing (i.e., black) inorganic/organic boundaries is supported. Along with the results for the hybrid SLs, we also plot the mean conductances derived from thermal conductivity measurements for W/Al_2O_3 ,⁵¹ and AlN/GaN⁵² SLs. Contrary to our hybrid SLs, the mean conductances in these inorganic based SLs increase with decreasing period thicknesses. In Ref. 52, this increase in h_K for the AlN/GaN SLs was attributed to phonons with long wavelengths carrying the majority of heat.

The second aspect worth noting is that the mean conductances derived are close to the 326 maximum conductance with $\zeta = 1$. We demonstrate this consistency over a wide range 327 of temperatures, shown in Fig. 6b, which plots $h_{\rm K}$ calculated for ZnO/HQ/ZnO interface 328 as a function of temperature for the two SLs with x=13.1 nm and 7.0 nm. The appre-329 ciable agreement between these values and the conductance in ZnO is consistent with the 330 analysis in Fig. 5 (treating all phonon mean free paths being limited by scattering at the 331 ZnO/HQ/ZnO interface), as mentioned above. This agreement also suggests that a large 332 portion of the phonon modes in the ZnO transmits ballistically across the ZnO/HQ/ZnO in-333 terface, implying relatively minor intrinsic thermal resistance in the molecular layer. While 334 the relatively minor disagreement between the maximal conductance (Fig. 6b, solid line) and 335 the data could imply some level of phonon-vibron interactions in the HQ layer, more rig-336 orous computational models are necessary to draw quantitative conclusions regarding these 337 diffusive scattering processes in the molecule. 338

In order to quantify the contribution of the vibrational properties of the organic layer on 339 phonon transmission across the ZnO/HQ/ZnO interfacial region, we calculate the average 340 phonon transmissions from the results in Fig. 6b (comparing the maximal conductance model) 341 to the data) and find interfacial transmissions of $\sim 76\%$ for the $(ZnO)_{7.0 \text{ nm}}/\text{HQ}$ sample and 342 $\sim 65\%$ for the (ZnO)_{13.1 nm}/HQ sample at room temperature. This deviation from "perfect" 343 transmission of phonons could be due to the fact that heat flux carried by phonons with 344 wavelengths longer than the organic molecular chain lengths are unaffected by the organic 345 layer, whereas phonons with wavelengths on the order of and smaller than the molecular 346 lengths are scattered due to the vibrational properties of the molecules (as discussed in more 347 detail in the Supplemental Material). We note that 75-91% of the phonon flux in ZnO is 348 carried by phonons with wavelengths longer than the average thickness of the HQ layer (Sup-349 plemental Material), supporting this hypothesis. We note that this hypothesis is consistent 350

with previous works suggesting that at interfaces, the transmission of phonon wavelengths greater than the characteristic length scales of nanoscale structures and asperities at solid interfaces are not affected by these non-idealities.^{5,6,52–55} More rigorous computational simulations are necessary to study this hypothesis in more detail, which includes a greater understanding of diffusive vibrational scattering in single-molecule thick films as previously mentioned.

One of the factors driving the high phonon transmission values across ZnO/HQ/ZnO 357 interfaces could be due to the high quality interfaces within the SLs and the precise control 358 over the thicknesses of the inorganic layers achieved via the layer-by-layer deposition of the 359 ALD/MLD technique.^{17,56} At the inorganic/organic interfaces, it has been shown through 360 first principles study that the HQ molecules are most probably attached to every other sur-361 face Zn site (50% surface coverage).⁵⁷ This implies that we can not rule out the possibility of 362 ZnO growth at the lateral interstitial positions, which could affect the phonon energy trans-363 mission across these inorganic/organic/inorganic interfaces; in principle this could happen if 364 the physical size of the HQ would prevent its reaction with all the Diethyl zinc terminated 365 surface sites. However, the systematically lower densities (predicted from XRR measure-366 ments, and reported in the Supplemental Materials) with increasing number of MLD cycles, 367 suggest that the presence of interstitial ZnO within the organic layers is unlikely. 368

The implication of large thermal transmission across the single HQ layer assumes that 369 there is no mismatch of acoustic impedance or vibrational spectra encountered by the im-370 pinging ZnO flux on the HQ monolayer. Although this would be true for a pure ZnO/ZnO 371 interface in which phonons are specularly scattered, this clearly would not be the case if 372 considering phonon thermal conductance limited by transmission across the ZnO/HQ/ZnO 373 interface due to properties of the HQ. To exemplify this more quantitatively, we performed 374 molecular dynamics simulations on a plane of HQ molecules to obtain the power spectral 375 density. The power spectral density is compared to the $D(\omega)$ spectrum for bulk ZnO cal-376 culated from the phonon dispersion,⁴⁴ and as expected, the relatively discrete modes in the 377 phonon frequencies calculated for the HQ layer do not completely overlap the $D(\omega)$ for ZnO 378 (Fig. S6 in Supplemental Material). Note, we do not attempt to separate the scattering 379 at the ZnO/HQ boundary from the internal scattering within the organic monolayers from 380 our MD simulations, which is beyond the scope of this study. However, from our predicted 381 phonon density of states for a confined HQ layer mimicking a 50 % surface coverage, we can 382

infer that under the typical DMM picture of phonon transmission from the ZnO across the
HQ and into the next ZnO layer, a HQ-limited transmission seems implausible.

To scope the generality of the discussions presented above, we derive the conductance 385 across the $TiO_2/HQ/TiO_2$ from the thermal conductivity measurement for the TiO_2 -based 386 SL at room temperature¹⁷ and compare the value to the result for a control sample with-387 out the HQ layers (Al/TiO₂/MgO). We determine $h_{\rm K} = 430 \pm 78$ MW m⁻² K⁻¹ for 388 $TiO_2/HQ/TiO_2$ interface, lower than that of the ZnO-based SLs at room temperature. 380 From this, we determine the phonon transmission across the $TiO_2/HQ/TiO_2$ interface to be 390 $\sim 41\%$. Further calculations of the spectral heat flux as a function of the wave-vector for 391 TiO_2 (Supplemental Material) demonstrates that the percent heat flux carried by phonons 392 with wavelengths shorter than $\sim 6-7$ Å in TiO₂ is $\sim 53-62\%$, in reasonable agreement with 393 the $\sim 41\%$ transmission determined for the TiO₂-based sample. 394

In order to investigate the role of molecular vibrations on the phonon scattering mecha-305 nisms, we measured the thermal conductivities of SLs with 3, 5 and 7 layers of HQ molecules 396 interspersed between x=7.0 nm thick ZnO layers at room temperature (see top panel of Fig. 7 397 for depictions of unit cells⁵⁷). As shown in Fig. 7a, increasing the number of MLD cycles 398 for the SLs decreases the thermal conductivity monotonically. Note, the prediction of Eq. 3 399 for x = 7 nm does not agree with the measurements for thicker HQ layers, which we ascribe 400 to ZnO phonons scattering in the organic layers due to the vibrational properties of the 401 thicker HQ layers. To further quantify the role of the vibrational resistance on these com-402 posite structures, we plot the mean thermal boundary resistance across the ZnO/HQ/ZnO 403 interface as a function of number of molecular layers in Fig. 7b as calculated from the series 404 resistor model. The linear trend in resistance as the HQ layer is increased from 3 to 7 layers 405 suggests that the internal diffusive scattering in the organic layer plays a significant role in 406 impeding thermal transport for SLs with greater than or equal to 3 layers of HQ in-between 407 the inorganic layers. We note that from GIXRD measurements, we do not observe a sig-408 nificant reduction in the crystallinity of the inorganic constituents due to inclusion of the 400 thicker HQ layers, implying that the reduction in thermal conductivities of these structures 410 with 3 to 7 HQ layers is mainly due to scattering at the thicker HQ layers. 411

We gain quantitative support for this result by calculating the average phonon transmission from the ZnO across the HQ layer using the approach discussed previously (transmissions shown in Fig. 7b). Increasing the MLD cycles from a monolayer to 3 HQ layers



Figure 7. Top panel depicts unit cells with increasing number of hydroquinone molecules. (a) Thermal conductivity measurements at room temperature as a function of the number of MLD cycles performed. Calculation of Eq. 2 for the inorganic layer thickness is also shown for comparison. The measured thermal conductivity for the SLs deviate from the prediction of Eq. 3 as the HQ layer thicknesses increase. (b) Effective resistances of inorganic/organic/inorganic interfaces with varying number of hydroquinone layers derived from the thermal conductivities shown in (a).

drastically reduces the transmission from 76% to 53%. Upon further increase in the number of HQ layers to 5 and 7, the transmissions reduce to 28% and 23%, respectively. Previous studies on the length dependent vibrational transport in molecular chains have mostly focused on self assembled monolayers of aliphatic alkane chains.^{27,58–60} Most of these studies have concluded that the conductance across molecular chains is insensitive to the length of the hydrocarbon chains, particularly in Ref. 60, it is shown that the conductance is constant

for chain lengths >20 carbon atoms. However, for shorter chain lengths, theoretical calcula-421 tions by Segal et. al.⁶⁰ and experimental data by Meier et. al.⁵⁹ suggest that conductance is 422 maximum for a chain length of up to 4 carbon atoms and decreases with increasing number 423 of carbon atoms thereafter to a certain chain length. From our results, the drastic reduction 424 in phonon transmission coefficients with thicker HQ layers compared to that of the SLs with 425 a monolayer of HQ molecule could be due to the diffusive nature of vibrational transport 426 in the longer chain molecules. However, as pointed out previously, we cannot comprehen-427 sively separate the resistances due to inorganic/organic interface scattering and the internal 428 scattering in the molecular layers. Therefore, we do not attempt to separate the intrinsic 429 thermal conductivity of the individual organic layers from the overall thermal conductivity 430 of the hybrid films. 431

432 IV. CONCLUSIONS

We conclude that the heat transfer mechanisms in hybrid SLs with single molecular layers 433 are driven by phonon-boundary scattering, where the entire spectrum of phonon mean free 434 paths in the inorganic layer is limited by scattering at the inorganic/organic interface. The 435 resulting thermal conductivities of these hybrid nanostructures are mainly limited by the 436 ZnO phonon flux and period spacing of the inorganic layers. Our analysis suggests that the 437 phonon flux in the inorganic layer, which scatters at the inorganic/organic interface, limits 438 the thermal conductivity of these nanostructures. The mean conductances derived from 439 the thermal conductivity measurements also suggest that scattering at the molecular layer 440 interfaces accounts for the majority of the reduction in the thermal conductivity of hybrid 441 SLs with single organic layers. By considering this as a thermal boundary conductance lim-442 ited processes, we hypothesize that phonons with wavelengths greater than the organic layer 443 thickness are transmitted across the organic layers after scattering at the inorganic/organic 444 interface; these phonon wavelengths make up >75% of the phonon flux in the ZnO, which 445 offers a concomitant picture of the heat transfer processes in inorganic/organic hybrid com-446 posites. By increasing the thickness of the MLD-grown layer, we observe a significant re-447 duction in the phonon transmission across the thicker molecular layers as compared to the 448 thermal conductance across the single organic layers. The linear trend in thermal resistance 440 with number of molecular layers suggests a diffusive scattering process in the MLD-grown or-450

ganic layer, which offers a robust opportunity for more focused theoretical or computational
studies to pinpoint the size effects in vibronic scattering in aromatic molecules.

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